

# OPAx391 Precision, Ultra-Low I<sub>Q</sub>, Low Offset Voltage, e-trim™ Operational Amplifiers

### 1 Features

- Low I<sub>Q</sub>: 24µA
- Gain bandwidth product: 1MHz
- · Low input bias current: 10fA
- Low offset voltage: ±45µV (maximum)
- Low drift: ±1.2µV/°C
- Low supply voltage operation: 1.7V to 5.5V
- Input common mode range ±100mV beyond rail
- Fast slew rate: 1V/µs
- · High load capacitance drive
- · High output current drive: 60mA
- Rail-to-rail output
- · EMI and RFI filtered inputs
- Small package options: SC-70, DSBGA

## 2 Applications

- · Portable electronics
- · Flow transmitter
- · Blood glucose monitor
- · Process analytics (pH, gas, force, humidity)
- · Temperature transmitter
- · Pressure transmitter
- Medical sensor patches
- · Building automation
- · Wearable fitness and activity monitor
- · Gas detector
- · Analog security camera

## 3 Description

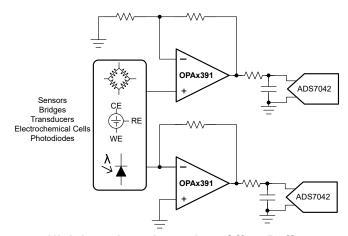
The OPA391, OPA2391, and OPA4391 (OPAx391) devices feature a unique combination of high bandwidth (1MHz) along with very-low quiescent current (24 $\mu$ A) in high-precision amplifiers. These features combined with rail-to-rail input and output make these devices an exceptional choice in highgain, low-power applications. Ultra-low input bias current of 10fA, only 45 $\mu$ V of offset (maximum), and 1.2 $\mu$ V/°C of drift over temperature help maintain high precision in ratiometric and amperometric sensor front ends that have demanding low-power requirements.

The OPAx391 use Texas Instruments' proprietary e-trim<sup>™</sup> operational amplifier technology, enabling a unique combination of ultra-low offset and low input offset drift without the need for any input switching or auto-zero techniques. The CMOS-based technology platform also features a modern, robust output stage design that is tolerant of high output capacitance, alleviating stability problems that are common in typical low-power amplifiers.

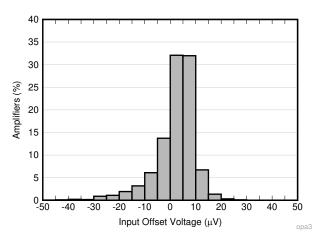
#### **Device Information**

PART NUMBER	CHANNEL COUNT	PACKAGE <sup>(1)</sup>	
OPA391	Single	DBV (SOT-23, 5) <sup>(2)</sup> DCK (SC70, 5) D (SOIC, 8) <sup>(2)</sup>	
OFASSI	DCK (SC70, 5)		
		D (SOIC, 8) <sup>(2)</sup>	
OPA2391	Dual DGK (		
		YBJ (DSBGA, 9)	
OPA4391	Quad	PW (TSSOP, 14)	

- (1) For more information, see Section 10.
- (2) Preview information (not Production Data).



High Input Impedance, Low Offset Buffer



OPA391 Offset Voltage



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# **4 Pin Configuration and Functions**

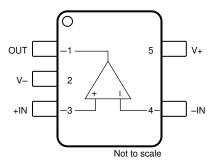


Figure 4-1. OPA391: DBV Package (Preview), 5-Pin SOT-23 (Top View)

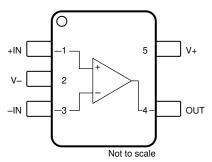


Figure 4-2. OPA391: DCK Package, 5-Pin SC-70 (Top View)

Table 4-1. Pin Functions: OPA391

	PIN				
NAME	N	0.	TYPE	DESCRIPTION	
INAIVIE	DBV (SOT-23)	DCK (SC70)			
-IN	4	3	Input	Inverting input	
+IN	3	1	Input	Noninverting input	
OUT	1	4	Output	Output	
V-	2	2	Power	Negative (lowest) power supply	
V+	5	5	Power	Positive (highest) power supply	



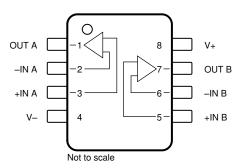


Figure 4-3. OPA2391: D Package (Preview), 8-pin SOIC and DGK Package, 8-Pin VSSOP (Top View)

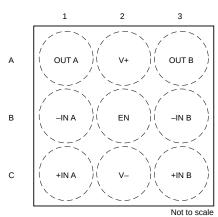


Figure 4-4. OPA2391: YBJ Package, 9-Pin DSBGA (Top View)

Table 4-2. Pin Functions: OPA2391

	PIN			
	N	0.	TYPE	DESCRIPTION
NAME	D (SOIC), DGK (VSSOP)	YBJ (DSBGA)	· · · · <del>-</del>	
EN	_	B2	Input	Enable pin. High = both amplifiers enabled.
–IN A	2	B1	Input	Inverting input, channel A
+IN A	3	C1	Input	Noninverting input, channel A
–IN B	6	B3	Input	Inverting input, channel B
+IN B	5	C3	Input	Noninverting input, channel B
OUT A	1	A1	Output	Output, channel A
OUT B	7	A3	Output	Output, channel B
V-	4	C2	Power	Negative (lowest) power supply
V+	8	A2	Power	Positive (highest) power supply



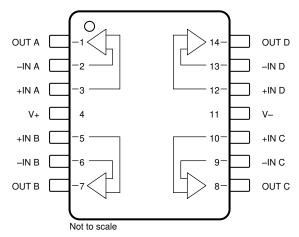


Figure 4-5. OPA4391: PW Package, 14-Pin TSSOP (Top View)

Table 4-3. Pin Functions: OPA4391

	PIN	TVDE	DESCRIPTION
NAME	NO.	TYPE	DESCRIPTION
-IN A	2	Input	Inverting input, channel A
+IN A	3	Input	Noninverting input, channel A
–IN B	6	Input	Inverting input, channel B
+IN B	5	Input	Noninverting input, channel B
–IN C	9	Input	Inverting input, channel C
+IN C	10	Input	Noninverting input, channel C
–IN D	13	Input	Inverting input, channel D
+IN D	12	Input	Noninverting input, channel D
OUT A	1	Output	Output, channel A
OUT B	7	Output	Output, channel B
OUT C	8	Output	Output, channel C
OUT D	14	Output	Output, channel D
V-	11	Power	Negative (lowest) power supply
V+	4	Power	Positive (highest) power supply

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# **5 Specifications**

## 5.1 Absolute Maximum Ratings

over operating free-air temperature range (unless otherwise noted)(1)

			MIN	MAX	UNIT	
Vs	Supply voltage, $V_S = (V+) - (V-)$	Single-supply		6	V	
VS	Supply voltage, vs = (v+) = (v=)	Dual-supply		±3	V	
	Input voltage, all pins	Common-mode	(V-) - 0.5	(V+) + 0.5	V	
	input voltage, all pills	Differential		(V+) - (V-) + 0.5	V	
	Input current, all pins	Input current, all pins		±10	mA	
	Output short circuit <sup>(2)</sup>		Continuous	Continuous		
T <sub>A</sub>	Operating temperature		<b>–</b> 55	150	°C	
TJ	Junction temperature		<b>–</b> 55	150	°C	
T <sub>stg</sub>	Storage temperature		-65	150	°C	

<sup>(1)</sup> Operation outside the Absolute Maximum Ratings may cause permanent device damage. Absolute Maximum Ratings do not imply functional operation of the device at these or any other conditions beyond those listed under Recommended Operating Conditions. If used outside the Recommended Operating Conditions but within the Absolute Maximum Ratings, the device may not be fully functional, and this may affect device reliability, functionality, performance, and shorten the device lifetime.

### 5.2 ESD Ratings

			VALUE	UNIT	
OPA391	and OPA2391				
.,	Human-body model (HBM), per ANSI/ESDA/JEDEC JS-001 <sup>(1)</sup>				
V <sub>(ESD)</sub>	Charged-device model (CDM), per ANSI/ESDA/JEDEC JS-002 <sup>(2)</sup>		±500	V	
OPA439	1				
\/	Electrostatic discharge	Human-body model (HBM), per ANSI/ESDA/JEDEC JS-001 <sup>(1)</sup>	±1000	V	
V <sub>(ESD)</sub>	Electrostatic discharge	Charged-device model (CDM), per ANSI/ESDA/JEDEC JS-002 <sup>(2)</sup>	±500	V	

<sup>(1)</sup> JEDEC document JEP155 states that 500-V HBM allows safe manufacturing with a standard ESD control process.

## **5.3 Recommended Operating Conditions**

over operating free-air temperature range (unless otherwise noted)

			MIN	NOM MAX	UNIT
Supply voltage,		Single-supply	1.7	5.5	V
V <sub>S</sub>	$V_{S} = (V+) - (V-)$	Dual-supply	±0.85	±2.75	V
	Differential input voltage		-0.5	0.5	V
т	Specified temperature	OPA391DCK, OPA2391YBJ	-40	125	°C
1 A	T <sub>A</sub> Specified temperature	OPA2391D, OPA2391DGK, OPA4391PW	-40	85	C

<sup>(2)</sup> Short-circuit to ground, one amplifier per package.

<sup>(2)</sup> JEDEC document JEP157 states that 250-V CDM allows safe manufacturing with a standard ESD control process.



## 5.4 Thermal Information: OPA391

		OPA391	
	THERMAL METRIC <sup>(1)</sup>	DCK (SC-70)	UNIT
		5 PINS	
R <sub>0JA</sub>	Junction-to-ambient thermal resistance	214	°C/W
R <sub>0</sub> JC(top)	Junction-to-case (top) thermal resistance	115	°C/W
$R_{\theta JB}$	Junction-to-board thermal resistance	58	°C/W
$\Psi_{JT}$	Junction-to-top characterization parameter	29	°C/W
$\Psi_{JB}$	Junction-to-board characterization parameter	58	°C/W
R <sub>θJC(bot)</sub>	Junction-to-case (bottom) thermal resistance	N/A	°C/W

<sup>(1)</sup> For more information about traditional and new thermal metrics, see the Semiconductor and IC Package Thermal Metrics application report.

### 5.5 Thermal Information: OPA2391

THERMAL METRIC(1)					
		D (SOIC)	DGK (VSSOP)	YBJ (DSBGA)	UNIT
		8 PINS	8 PINS	9 PINS	
R <sub>θJA</sub>	Junction-to-ambient thermal resistance	132.8	152.1	110.7	°C/W
R <sub>0</sub> JC(top)	Junction-to-case (top) thermal resistance	72.7	61.7	0.7	°C/W
$R_{\theta JB}$	Junction-to-board thermal resistance	76.3	86.8	32.1	°C/W
$\Psi_{JT}$	Junction-to-top characterization parameter	22.6	5.2	0.3	°C/W
$\Psi_{JB}$	Junction-to-board characterization parameter	75.6	85.5	32.1	°C/W
R <sub>0JC(bot)</sub>	Junction-to-case (bottom) thermal resistance	N/A	N/A	N/A	°C/W

<sup>(1)</sup> For more information about traditional and new thermal metrics, see the Semiconductor and IC Package Thermal Metrics application report.

### 5.6 Thermal Information: OPA4391

		OPA4391	
	THERMAL METRIC <sup>(1)</sup>	PW (TSSOP)	UNIT
		14 PINS	
$R_{\theta JA}$	Junction-to-ambient thermal resistance	109.6	°C/W
R <sub>0JC(top)</sub>	Junction-to-case (top) thermal resistance	27.4	°C/W
$R_{\theta JB}$	Junction-to-board thermal resistance	56.1	°C/W
$\Psi_{JT}$	Junction-to-top characterization parameter	1.5	°C/W
$\Psi_{JB}$	Junction-to-board characterization parameter	54.9	°C/W
$R_{\theta JC(bot)}$	Junction-to-case (bottom) thermal resistance	N/A	°C/W

(1) For more information about traditional and new thermal metrics, see the <u>Semiconductor and IC Package Thermal Metrics</u> application report.

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## 5.7 Electrical Characteristics: OPA391DCK and OPA2391YBJ

at  $V_S$  = 1.7 V to 5.5 V,  $T_A$  = 25°C,  $R_L$  = 10 k $\Omega$ , and  $V_{CM}$  =  $V_S$  / 2 (unless otherwise noted)

F	PARAMETER	TES	T CONDITIONS	MIN	TYP	MAX	UNIT
OFFSET	VOLTAGE						
		V <sub>S</sub> = 5.0 V			±10	±45	
		$V_{CM} = (V+) - 0.3 \text{ V}, V_{S} =$	5.0 V		±60	±750	.,
Vos	Input offset voltage	04 > 04 > 4			±15	±80	μV
		$V_{CM} = (V-) - 0.1 V$	$T_A = -40^{\circ}C \text{ to } +125^{\circ}C^{(1)}$			±600	
d\/ /dT	Input offset voltage	$T_A = 0$ °C to $85$ °C <sup>(1)</sup>	-		±1	±5	μV/°C
dV <sub>OS</sub> /dT	drift	$T_A = -40^{\circ}\text{C to } +125^{\circ}\text{C}^{(1)}$			±1.2	±6	μν/ С
PSRR	Power supply rejection ratio	V <sub>CM</sub> = (V–) – 0.1 V				40	μV/V
INPUT BI	IAS CURRENT	1				·	
		$T_A = 25^{\circ}C^{(1)}$			±0.01	0.8	
	In mark his a command	$T_A = 0$ °C to $85$ °C <sup>(1)</sup>				5	^
I <sub>B</sub>	Input bias current	T - 40°C to 1405°C(1)	OPA391DCK			30	pA
		$T_A = -40^{\circ}\text{C to } +125^{\circ}\text{C}^{(1)}$	OPA2391YBJ			35	
		$T_A = 25^{\circ}C^{(1)}$	-		±0.01	0.8	
Ios	Input offset current	$T_A = 0$ °C to 85°C <sup>(1)</sup>				5	pА
		$T_A = -40$ °C to +125°C <sup>(1)</sup>		30			
NOISE							
	Input voltage noise	f = 0.1 Hz to 10 Hz, V <sub>CM</sub> =	- (\/_)		0.91		μV <sub>RMS</sub>
	input voltage noise	7 - 0.1112 to 10112, V <sub>CM</sub> -	- (v–)		6.0		$\mu V_{PP}$
		f = 10 Hz			130		
e <sub>n</sub>	Input voltage poice	f = 1 kHz	f = 1 kHz		60		nV/√ <del>Hz</del>
	,	f = 10 kHz			55		
i <sub>n</sub>	Input current noise density	f = 1 kHz			30		fA/√Hz
INPUT V	OLTAGE			-		'	
V <sub>CM</sub>	Common-mode voltage	$T_A = -40^{\circ}\text{C to } +125^{\circ}\text{C}^{(1)}$		(V-) - 0.1		(V+) + 0.1	V
		(V−) − 0.1 V ≤ V <sub>CM</sub> ≤	OPA391DCK	89	100		
		(V+) – 1.5 V	OPA2391YBJ		100		
CMRR	Common-mode rejection ratio	(V−) − 0.1 V ≤ V <sub>CM</sub> ≤		100	121		dB
	rejection ratio	$(V+) - 1.5 \text{ V}, \text{ V}_S = 5.5 \text{ V}$	$T_A = -40^{\circ}C \text{ to } +125^{\circ}C^{(1)}$	90	100		
		$(V+) - 0.6 \ V \le V_{CM} \le (V+)$	+ 0.1 V		69		
INPUT IN	IPEDANCE	•				'	
Z <sub>id</sub>	Differential input impedance				0.1    1		GΩ    pF
Z <sub>ic</sub>	Common-mode input impedance				1    1		TΩ    pF



## 5.7 Electrical Characteristics: OPA391DCK and OPA2391YBJ (continued)

at  $V_S$  = 1.7 V to 5.5 V,  $T_A$  = 25°C,  $R_L$  = 10 k $\Omega$ , and  $V_{CM}$  =  $V_S$  / 2 (unless otherwise noted)

	PARAMETER	TES	T CONDITIONS	MIN	TYP	MAX	UNIT
OPEN-L	LOOP GAIN						
		V <sub>S</sub> = 5.5 V	(V-) + 0.1 V < V <sub>O</sub> < (V+) - 0.1 V, V <sub>CM</sub> = (V-) -100 mV	100	121		
A <sub>OL</sub>	Open-loop voltage	V <sub>S</sub> = 3.3 V	$(V-) + 0.45 V < V_O < (V+) - 0.45 V,$ $V_{CM} = (V-) -100 \text{ mV}, R_L = 2 \text{ k}\Omega$	100	121		dB
COL	gain	V <sub>S</sub> = 1.7 V	$(V-) + 0.1 V < V_O < (V+) - 0.1 V,$ $V_{CM} = (V+) - 1.5 V$	90	113		uБ
		VS - 1.7 V	$(V-) + 0.45 V < V_O < (V+) - 0.45 V,$ $V_{CM} = (V+) - 1.5 V, R_L = 2 k\Omega$	90	107		
FREQU	ENCY RESPONSE						
	I limite a main		Ι <sub>ΟUT</sub> = 0 μΑ		450		kHz
UGB	Unity-gain bandwidth	G = 1	$I_{OUT} = 0 \mu A, R_L = 50 k\Omega$		0.85		MHz
			I <sub>OUT</sub> = 100 μA		0.75		1711 12
GBW	Gain-bandwidth product	No load			MHz		
SR	Slew rate	G = -1, 4-V step 1					
t <sub>S</sub>	Settling time	To 0.1%, $V_S = 5.5 \text{ V}$ , $G = 1$	l, 1-V step		8		μs
t <sub>OR</sub>	Overload recovery time	$V_{IN} \times G = V_{S}$			15		μs
OUTPU	Т						
		No load			3		
	Voltage output swing from rail					10	
$V_O$		$R_L = 2 k\Omega$			40	mV	
		$T_A = -40^{\circ}\text{C to } +125^{\circ}\text{C}^{(1)}$	OPA391DCK			10	
		1A = -40 C to 1125 C	OPA2391YBJ			12	
I <sub>SC</sub>	Short-circuit current	V <sub>S</sub> = 5.5 V		45	60		mA
Z <sub>O</sub>	Open-loop output impedance	f = 1 MHz, no load			1.6		kΩ
POWER	RSUPPLY						
	Quiescent current	V <sub>CM</sub> = (V+) – 1.5 V			23.5	30	
IQ	per amplifier	V <sub>CM</sub> = (V+) = 1.5 V	$T_A = -40^{\circ}C \text{ to } +125^{\circ}C^{(1)}$			32	μA
SHUTD	OWN (OPA2391YBJ O	nly)					
I <sub>QSD</sub>	Quiescent current per amplifier <sup>(2)</sup>	All amplifiers disabled, EN	I = (V–)		3.5		μΑ
V <sub>IH</sub>	High-level input voltage <sup>(2)</sup>	Amplifier enabled		(V+) – 0.5			V
V <sub>IL</sub>	Low-level input voltage <sup>(2)</sup>	Amplifier disabled			(V-) + 0.5	V	
t <sub>ON</sub>	Amplifier enable time <sup>(2)</sup>	G = 1, $V_{OUT} = 0.9 \times V_{S}/2^{(3)}$	3)		75		μs
t <sub>OFF</sub>	Amplifier disable time <sup>(2)</sup>	$G = 1, V_{OUT} = 0.1 \times V_{S}/2^{(3)}$	3)		4		μs
	EN pin input	V <sub>IH</sub> = (V+)			±0.01		^
	leakage current <sup>(2)</sup>	V <sub>IL</sub> = (V–)			-0.3		μΑ

<sup>(1)</sup> Specification established from device population bench system measurements across multiple lots.

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<sup>(2)</sup> Specified by design and characterization; not production tested.

<sup>(3)</sup> Disable time (t<sub>OFF</sub>) and enable time (t<sub>ON</sub>) are defined as the time between the 50% point of the signal applied to the EN pin and the point at which the output voltage reaches the 10% (disable) or 90% (enable) level.



## 5.8 Electrical Characteristics: OPA2391DGK and OPA4391PW

at  $V_S$  = 1.7 V to 5.5 V,  $T_A$  = 25°C,  $R_L$  = 10 k $\Omega$ , and  $V_{CM}$  =  $V_S$  / 2 (unless otherwise noted)

PARAMETER		TE	MIN	TYP	MAX	UNIT		
OFFSET	VOLTAGE			-				
			OPA2391DGK		±10	±70		
		V <sub>S</sub> = 5.0 V	OPA4391PW		±10	±85		
Vos	Input offset voltage		$V_{CM} = (V+) - 0.3 V$		±60	±750	μV	
		V - (V ) 0 4 V	OPA2391DGK		±15	±85		
		$V_{CM} = (V-) - 0.1 V$	OPA4391PW		±15	±80		
dV <sub>OS</sub> /dT	Input offset voltage drift	T <sub>A</sub> = 0°C to 85°C <sup>(1)</sup>			±1	±5	μV/°C	
PSRR	Power supply rejection ratio	V <sub>CM</sub> = (V–) – 0.1 V				40	μV/V	
INPUT BI	IAS CURRENT			,				
1	Input bias current	$T_A = 25^{\circ}C^{(1)}$			±0.01	0.8		
I <sub>B</sub> Input bias current		$T_A = 0$ °C to 85°C <sup>(1)</sup>			5	pA		
I <sub>OS</sub> Input offset current		$T_A = 25^{\circ}C^{(1)}$		±0.01	0.8	pA		
los	input onset current	$T_A = 0^{\circ}C \text{ to } 85^{\circ}C^{(1)}$				5	pΑ	
NOISE								
	Input voltage noise	f = 0.1 Hz to 10 Hz, V <sub>CM</sub>	. = (\/_)		0.91		$\mu V_{\text{RMS}}$	
	Input voltage noise	7 - 0.1112 to 10112, V <sub>CN</sub>		6.0		$\mu V_{PP}$		
		f = 10 Hz			130			
e <sub>n</sub>	Input voltage noise density	f = 1 kHz		60		nV/√ <del>Hz</del>		
	,	f = 10 kHz			55			
i <sub>n</sub>	Input current noise density	f = 1 kHz			30		$fA/\sqrt{Hz}$	
INPUT V	OLTAGE							
$V_{CM}$	Common-mode voltage	$T_A = -40^{\circ}\text{C to } +85^{\circ}\text{C}^{(1)}$		(V-) - 0.1		(V+) + 0.1	V	
		$(V-) - 0.1 V \le V_{CM} \le$		86	100			
CMRR	Common-mode rejection ratio	(V+) – 1.5 V	V <sub>S</sub> = 5.5 V	100	121		dB	
	,	$(V+) - 0.6 V \le V_{CM} \le (V-V)$		69				
INPUT IM	IPEDANCE							
Z <sub>id</sub>	Differential input impedance				0.1    1		GΩ    pF	
Z <sub>ic</sub>	Common-mode input impedance				1    1		TΩ    pF	



## 5.8 Electrical Characteristics: OPA2391DGK and OPA4391PW (continued)

at  $V_S$  = 1.7 V to 5.5 V,  $T_A$  = 25°C,  $R_L$  = 10 k $\Omega$ , and  $V_{CM}$  =  $V_S$  / 2 (unless otherwise noted)

	PARAMETER	Т	EST CONDITIONS	MIN	TYP	MAX	UNIT
OPEN-	LOOP GAIN						
		V <sub>S</sub> = 5.5 V	$(V-) + 0.1 V < V_O < (V+) - 0.1 V,$ $V_{CM} = (V-) -100 \text{ mV}$	100	121		
٨	Open-loop voltage	V <sub>S</sub> = 5.5 V	$(V-) + 0.45 V < V_O < (V+) - 0.45 V,$ $V_{CM} = (V-) -100 \text{ mV}, R_L = 2 \text{ k}\Omega$	100	121		dB
A <sub>OL</sub>	gain	V <sub>S</sub> = 1.7 V	$(V-) + 0.1 V < V_O < (V+) - 0.1 V,$ $V_{CM} = (V+) - 1.5 V$	90	113		uБ
		VS - 1.7 V	$(V-) + 0.45 V < V_O < (V+) - 0.45 V,$ $V_{CM} = (V+) - 1.5 V, R_L = 2 k\Omega$	86	107		
FREQU	ENCY RESPONSE						
			Ι <sub>ΟUT</sub> = 0 μΑ		450		kHz
UGB	Unity-gain bandwidth	G = 1	$I_{OUT}$ = 0 $\mu$ A, $R_L$ = 50 $k\Omega$		0.85		MHz
	barrawiaar		Ι <sub>ΟUT</sub> = 100 μΑ		0.75		IVITIZ
GBW	Gain-bandwidth product	No load		1		MHz	
SR	Slew rate	G = -1, 4-V step			1		V/µs
t <sub>S</sub>	Settling time	To 0.1%, V <sub>S</sub> = 5.5 V, G	= 1, 1-V step		8		μs
t <sub>OR</sub>	Overload recovery time	$V_{IN} \times G = V_{S}$			15		μs
OUTPL	т					'	
		No load				3	
Vo	Voltage output swing from rail					10	mV
	J	R <sub>L</sub> = 2 kΩ			40		
I <sub>SC</sub>	Short-circuit current	V <sub>S</sub> = 5.5 V		45	60		mA
Z <sub>O</sub>	Open-loop output impedance	f = 1 MHz, no load			1.6		kΩ
POWE	R SUPPLY						
	Quiescent current	V = (V+) 1.5.V			23.5	30	
IQ	per amplifier	$V_{CM} = (V+) - 1.5 V$	$T_A = -40^{\circ}\text{C to } + 125^{\circ}\text{C}^{(1)}$			32	μA

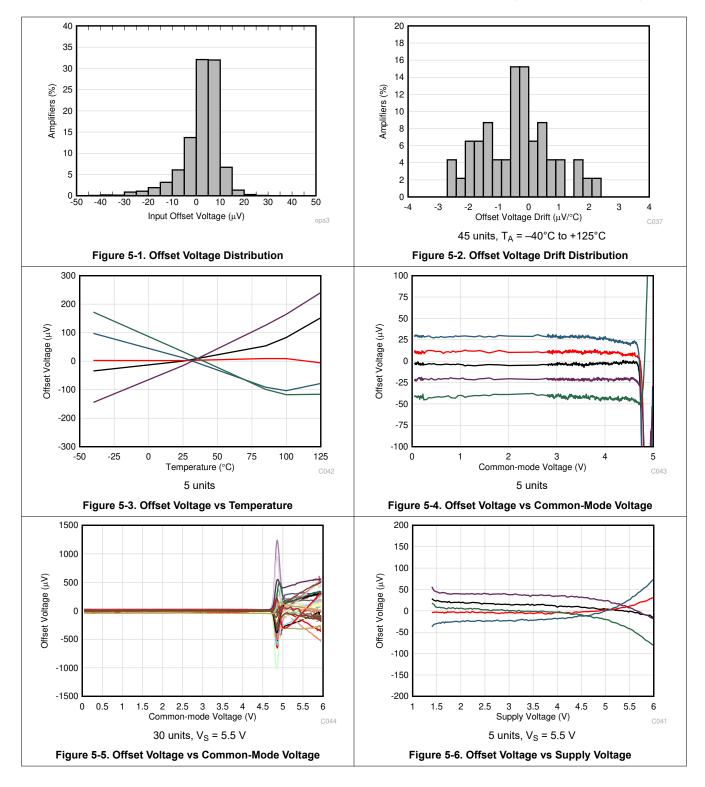
<sup>(1)</sup> Specification established from device population bench system measurements across multiple lots.

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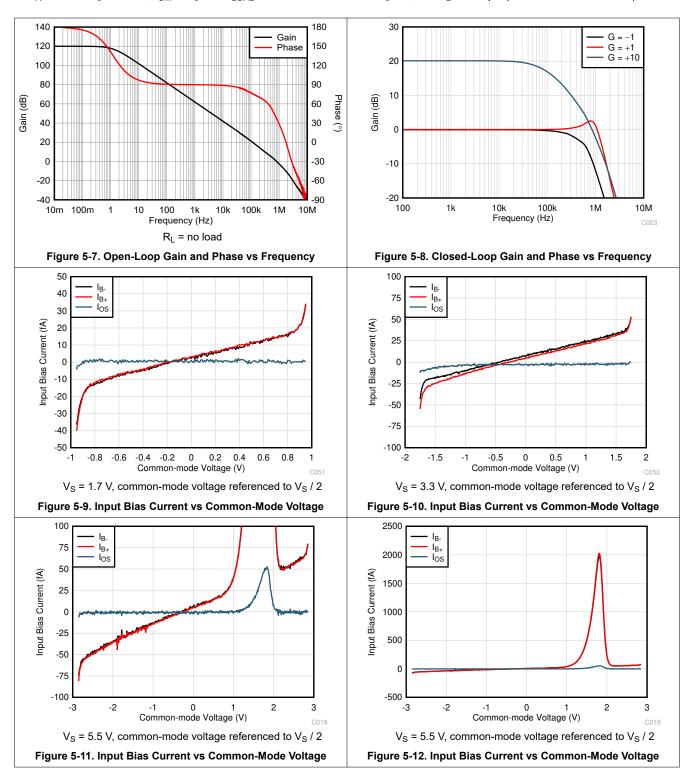
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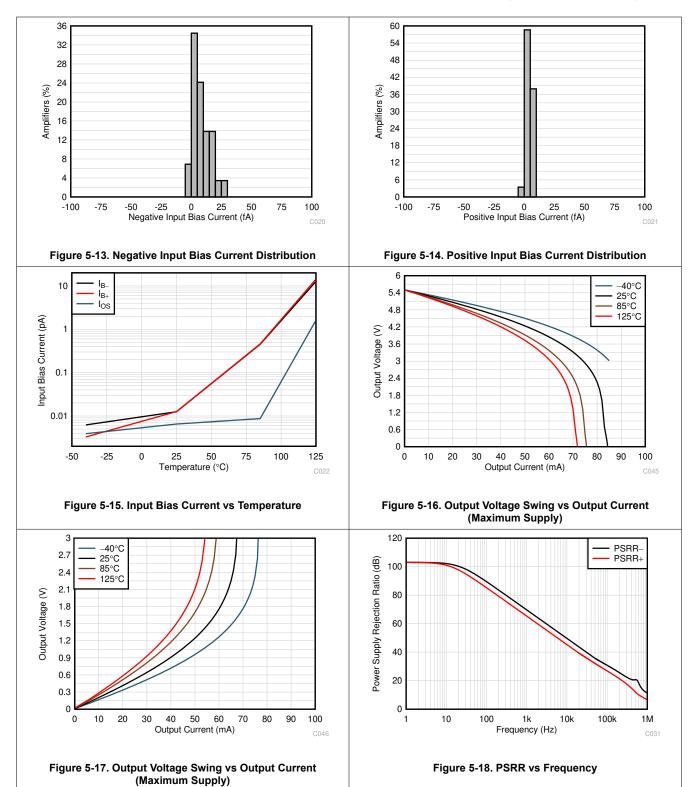
### 5.9 Typical Characteristics



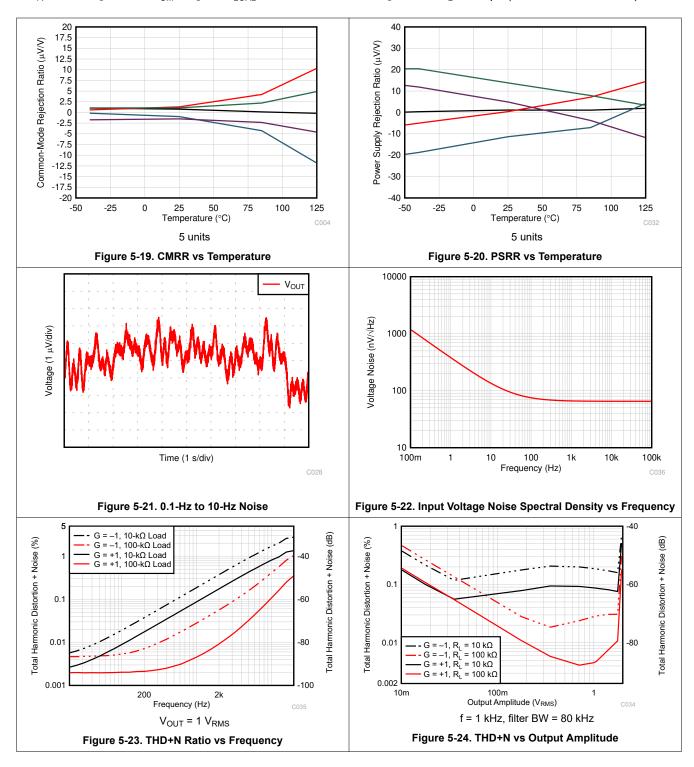




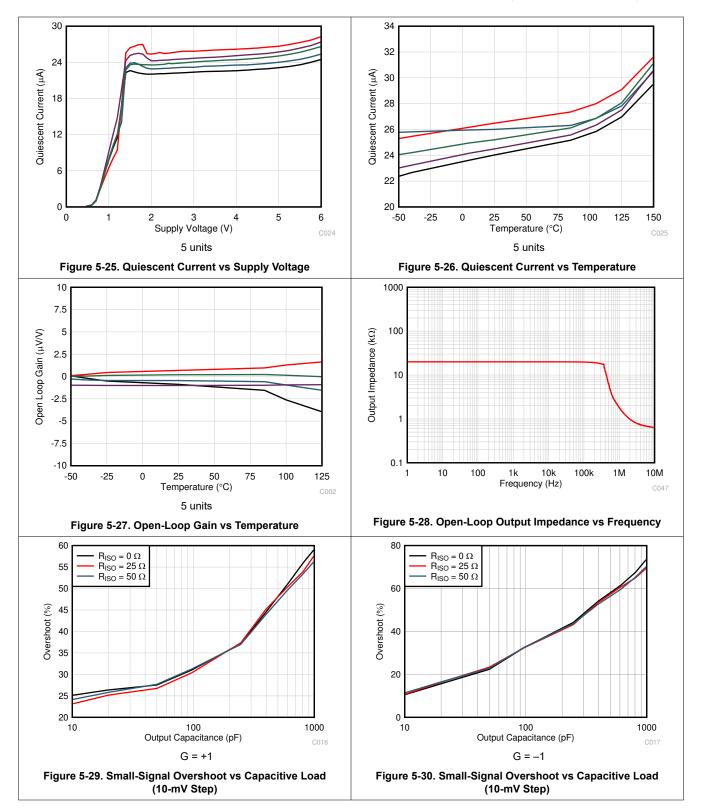




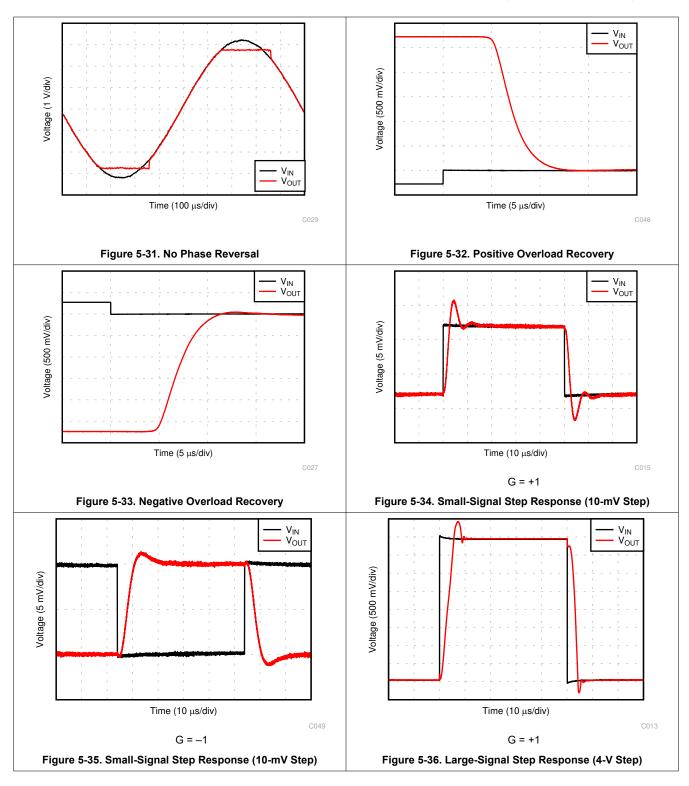




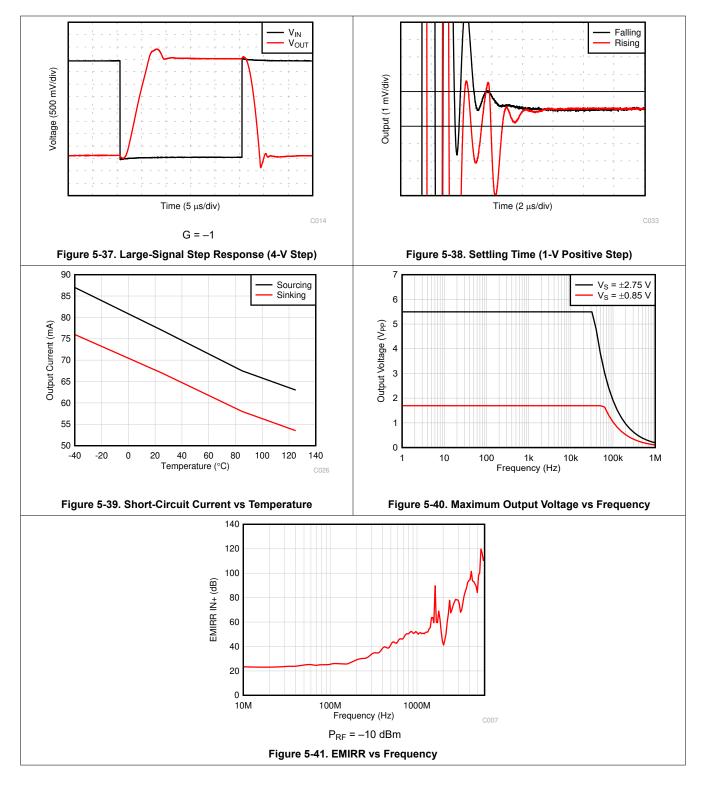












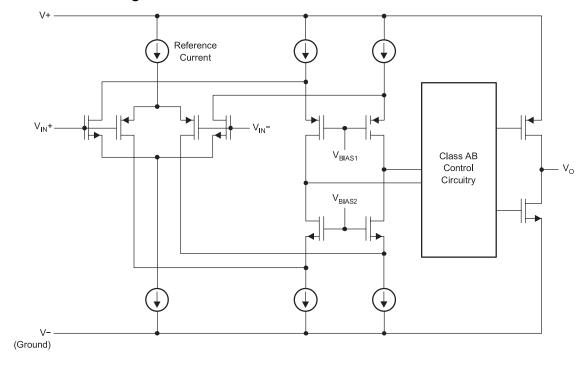
## **6 Detailed Description**

### 6.1 Overview

The OPAx391 are low-offset, low-power, e-trim operational amplifiers (op amps) that uses a proprietary offset trim technique. These op amps offer ultra-low input offset voltage, drift, and input bias current, while achieving an excellent bandwidth-to-quiescient-current ratio. The OPAx391 operate from 1.7 V to 5.5 V, are unity-gain stable, and are designed for a wide range of general-purpose and precision applications.

The output features an advanced output stage that tolerates high capacitive loading for solid and stable performance. The OPAx391 strengths make these devices an excellent amplifier for high-impedance sensors, where input bias current, offset voltage, and power consumption are critical.

## 6.2 Functional Block Diagram



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### 6.3 Feature Description

### 6.3.1 Low Input Bias Current

The OPAx391 achieve very low input bias current as a result of CMOS inputs and advanced electrostatic discharge (ESD) protection circuitry. Input bias current ( $I_B$ ) is primarily a function of the input protection scheme in CMOS input amplifiers. If careful consideration is not taken with the ESD cells, a CMOS input device can exhibit large input bias currents, especially over temperature. The OPAx391 achieve excellent input bias current ratings of  $\pm 30$  pA maximum at  $125^{\circ}$ C.

## 6.3.2 Input Differential Voltage

The OPAx391 do not have any diodes connected between the input nodes, allowing for input voltages anywhere between the supply voltage. The input structure can be seen in Figure 6-1. Although these devices can tolerate any differential input voltage that does not exceed the supply voltage, do not operate continuously at differential input voltages greater than 0.5 V.

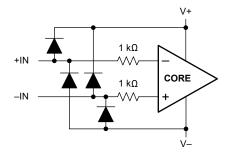


Figure 6-1. Equivalent Input Circuit

### 6.3.3 Capacitive Load Drive

The OPAx391 feature advanced output drive circuitry that maintain stability even with capacitive loads as high as 1 nF. Many low-quiescent-current amplifiers exhibit poor stability when connected to a capacitive load as a result of the low levels of current used to bias the output stage. The OPAx391 are designed with an output stage that adapts to high capacitive loads without sacrificing additional current consumption. This feature helps produce a highly stable device across all temperature and supply conditions, enabling robust system performance.

#### 6.3.4 EMI Rejection

The OPAx391 use integrated electromagnetic interference (EMI) filtering to reduce the effects of EMI interference from sources such as wireless communications and densely-populated boards with a mix of analog signal chain and digital components. EMI immunity can be improved with circuit design techniques; the OPAx391 benefit from these design improvements. Texas Instruments has developed the ability to accurately measure and quantify the immunity of an operational amplifier over a broad frequency spectrum extending from 10 MHz to 6 GHz. Figure 6-2 shows the results of this testing on the OPAx391. Table 6-1 lists the EMIRR +IN values for the OPAx391 at particular frequencies commonly encountered in real-world applications. Applications listed in Table 6-1 can be centered on or operated near the particular frequency shown. Detailed information can also be found in the *EMI Rejection Ratio of Operational Amplifiers* application report, available for download from www.ti.com.

The electromagnetic interference (EMI) rejection ratio, or EMIRR, describes the EMI immunity of operational amplifiers. An adverse effect that is common to many op amps is a change in the offset voltage as a result of RF signal rectification. An op amp that is more efficient at rejecting this change in offset as a result of EMI has a higher EMIRR and is quantified by a decibel value. Measuring EMIRR can be performed in many ways, but this section provides the EMIRR +IN, which specifically describes the EMIRR performance when the RF signal is applied to the noninverting input pin of the op amp. In general, only the noninverting input is tested for EMIRR for the following three reasons:

- 1. Op amp input pins are known to be the most sensitive to EMI, and typically rectify RF signals better than the supply or output pins.
- 2. The noninverting and inverting op amp inputs have symmetrical physical layouts and exhibit nearly matching EMIRR performance.
- 3. EMIRR is more simple to measure on noninverting pins than on other pins because the noninverting input pin can be isolated on a PCB. This isolation allows the RF signal to be applied directly to the noninverting input pin with no complex interactions from other components or connecting PCB traces.

High-frequency signals conducted or radiated to any pin of the operational amplifier can result in adverse effects because the amplifier does not have sufficient loop gain to correct for signals with spectral content outside the bandwidth. Conducted or radiated EMI on inputs, power supply, or output can result in unexpected dc offsets, transient voltages, or other unknown behavior. Make sure to properly shield and isolate sensitive analog nodes from noisy radio signals, digital clocks, and interfaces.

The EMIRR +IN of the OPAx391 is plotted versus frequency as shown in Figure 6-2. The OPAx391 unity-gain bandwidth is 1 MHz. EMIRR performance less than this frequency denotes interfering signals that fall within the op amp bandwidth.

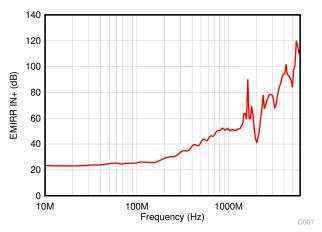


Figure 6-2. EMIRR Testing

Table 6-1. OPAx391 EMIRR IN+ for Frequencies of Interest

FREQUENCY	APPLICATION AND ALLOCATION	EMIRR IN+
400 MHz	Mobile radio, mobile satellite, space operation, weather, radar, ultra-high frequency (UHF) applications	39.1 dB
900 MHz	Global system for mobile communications (GSM) applications, radio communication, navigation, GPS (to 1.6 GHz), GSM, aeronautical mobile, UHF applications	46.5 dB
1.8 GHz	GSM applications, mobile personal communications, broadband, satellite, L-band (1 GHz to 2 GHz)	61.3 dB
2.4 GHz	802.11b, 802.11g, 802.11n, Bluetooth®, mobile personal communications, industrial, scientific and medical (ISM) radio band, amateur radio and satellite, S-band (2 GHz to 4 GHz)	69.8 dB
3.6 GHz	Radiolocation, aero communication and navigation, satellite, mobile, S-band	82.5 dB
5 GHz	802.11a, 802.11n, aero communication and navigation, mobile communication, space and satellite operation, C-band (4 GHz to 8 GHz)	83.6 dB

## **6.4 Device Functional Modes**

The OPAx391 have a single functional mode and are operational when the power-supply voltage is greater than  $1.7 \text{ V} (\pm 0.85 \text{ V})$ . The maximum specified power-supply voltage for the OPAx391 is  $5.5 \text{ V} (\pm 2.75 \text{ V})$ .

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## 7 Application and Implementation

#### Note

Information in the following applications sections is not part of the TI component specification, and TI does not warrant its accuracy or completeness. TI's customers are responsible for determining suitability of components for their purposes, as well as validating and testing their design implementation to confirm system functionality.

## 7.1 Application Information

The OPAx391 are unity-gain stable, precision operational amplifier free from unexpected output and phase reversal. The OPAx391 are optimized for full rail-to-rail input, allowing for low-voltage, single-supply operation or split-supply use. These miniature, high-precision, low-noise amplifiers offer high-impedance inputs that have a common-mode range 100 mV beyond the supplies and can tolerate the full supply voltage across the input. The OPAx391 precision amplifier is designed for sensor amplification, low-power analog signal chain applications in low or high gains, as well as a low-power discrete MOSFET or bipolar driver.

## 7.2 Typical Applications

#### 7.2.1 Three-Terminal CO Gas Sensor

Figure 7-1 shows a simple micropower potentiostat circuit for use with three-terminal unbiased CO sensors. This same design is applicable to many other type of three-terminal gas sensors or electrochemical cells. The basic sensor has three electrodes: the sense or working electrode (WE), counter electrode (CE), and reference electrode (RE). A current flows between CE and WE proportional to the detected concentration. The RE monitors the potential of the internal reference point. For an unbiased sensor, the WE and RE must be maintained at the same potential by adjusting the bias on CE. Through the potentiostat circuit formed by U1, the servo feedback action maintains the RE pin at a potential set by  $V_{REF}$ . R1 maintains stability as a result of the large capacitance of the sensor. C1 and R2 form the potentiostat integrator and set the feedback time constant. U2 forms a transimpedance amplifier (TIA) to convert the resulting sensor current into a proportional voltage. Equation 1 calculates the transimpedance gain, and resulting sensitivity, using R<sub>F</sub>:

$$V_{TIA} = (-I \times R_F) + V_{REF} \tag{1}$$

 $R_{Load}$  is a load resistor with a value that is normally specified by the sensor manufacturer (typically, 10  $\Omega$ ). The potential at WE is set by the applied  $V_{REF}$ .

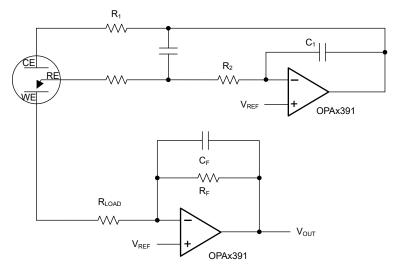


Figure 7-1. Three-Terminal CO Gas Sensor

#### 7.2.1.1 Design Requirements

For this example, Figure 7-2 shows an electrical model of a CO sensor is used to simulate the sensor performance. The simulation is designed to model a CO sensor with a sensitivity of 69 nA/ppm. The supply voltage and maximum analog-to-digital converter (ADC) input voltage is 2.5 V, and the maximum concentration is 300 ppm.

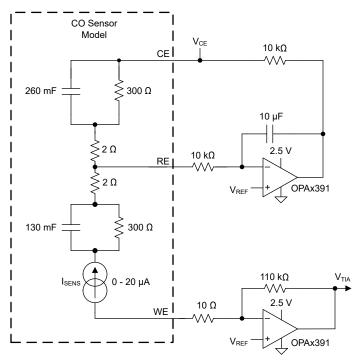


Figure 7-2. CO Sensor Simulation Schematic

### 7.2.1.2 Detailed Design Procedure

First, determine the  $V_{REF}$  voltage. This voltage is a compromise between maximum headroom and resolution, as well as allowance for the minimum swing on the CE terminal because the CE terminal generally goes negative in relation to the RE potential as the concentration (sensor current) increases. Bench measurements found the difference between CE and RE to be 180 mV at 300 ppm for this particular sensor. To allow for negative CE swing, footroom, and voltage drop across the 10-k $\Omega$  resistor, 300 mV is chosen for  $V_{REF}$ .

$$V_{ZERO} = V_{REF} = 300 \text{ mV}$$
 (2)

#### where

- V<sub>REF</sub> is the reference voltage (300 mV).
- V<sub>ZERO</sub> is the concentration voltage (300 mV).

Next, calculate the maximum sensor current at highest expected concentration:

$$I_{SENSMAX} = I_{PERPPM} \times ppmMAX = 69 \text{ nA} \times 300 \text{ ppm} = 20.7 \text{ } \mu\text{A}$$
(3)

#### where

- I<sub>SENSMAX</sub> is the maximum expected sensor current.
- I<sub>PERPPM</sub> is the manufacturer specified sensor current in amperes per ppm.
- ppmMAX is the maximum required ppm reading.



Then, find the available output swing range greater than the reference voltage available for the measurement:

$$V_{SWING} = V_{OUTMAX} - V_{ZERO} = 2.5 V - 0.3 V = 2.2 V$$
 (4)

### where

- V<sub>SWING</sub> is the expected change in output voltage.
- V<sub>OUTMAX</sub> is the maximum amplifier output swing.

Finally, calculate the transimpedance resistor  $(R_F)$  value using the maximum swing and the maximum sensor current:

$$R_F = \frac{V_{SWING}}{I_{SENSMAX}} = \frac{2.2 \text{ V}}{20.7 \text{ } \mu\text{A}} = 106.28 \text{ k}\Omega \text{ (use } 110 \text{ k}\Omega \text{ for a common value)}$$
 (5)

### 7.2.1.3 Application Curve

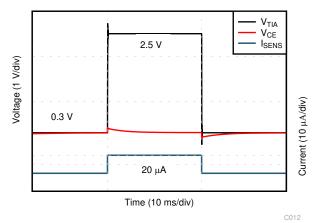


Figure 7-3. Sensor Transient Response to Simulated 300-ppm CO Exposure

### 7.2.2 4-mA to 20-mA Loop Design

Factory automation systems commonly use the 4-mA to 20-mA (4-20 mA) communication protocol to enable process automation. In typical 2-wire, 4-mA to 20-mA loop applications, power to the remote transmitter is limited to less than 4 mA total consumption. As a result of the power limitations, low power consumption is essential. The OPAx391 solves many design challenges in 4-mA to 20-mA loop applications, where low power, high accuracy, and high bandwidth are required.

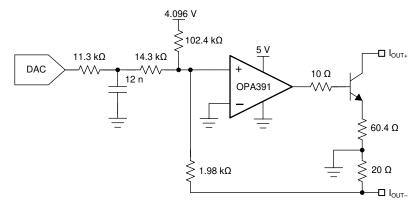


Figure 7-4. 4-20 mA Loop Interface Schematic

### 7.2.2.1 Application Curve

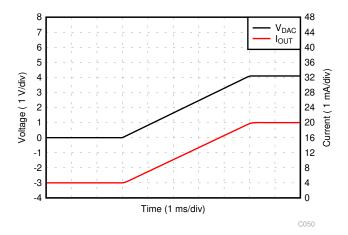


Figure 7-5. 4-mA to 20-mA Loop Response

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## 7.3 Power Supply Recommendations

The OPAx391 devices are specified for operation from 1.7 V to 5.5 V (±0.85 V to ±2.75 V).

### 7.4 Layout

### 7.4.1 Layout Guidelines

Paying attention to good layout practice is always recommended:

- Keep traces short.
- When possible, use a printed-circuit board (PCB) ground plane with surface-mount components placed as close as possible to the device pins.
- Place a 0.1-µF capacitor closely across the supply pins.

These guidelines must be applied throughout the analog circuit to improve performance and provide benefits, such as reducing the electromagnetic interference (EMI) susceptibility.

### 7.4.2 Layout Example

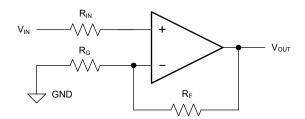


Figure 7-6. Schematic Representation

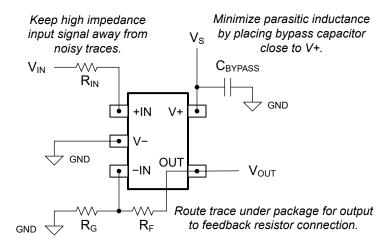


Figure 7-7. Layout Example

## 8 Device and Documentation Support

### 8.1 Device Support

### 8.1.1 Development Support

## 8.1.1.1 PSpice® for TI

PSpice® for TI is a design and simulation environment that helps evaluate performance of analog circuits. Create subsystem designs and prototype solutions before committing to layout and fabrication, reducing development cost and time to market.

### 8.1.1.2 TINA-TI™ Simulation Software (Free Download)

TINA-TI™ simulation software is a simple, powerful, and easy-to-use circuit simulation program based on a SPICE engine. TINA-TI simulation software is a free, fully-functional version of the TINA™ software, preloaded with a library of macromodels, in addition to a range of both passive and active models. TINA-TI simulation software provides all the conventional dc, transient, and frequency domain analysis of SPICE, as well as additional design capabilities.

Available as a free download from the Design and simulation tools web page, TINA-TI simulation software offers extensive post-processing capability that allows users to format results in a variety of ways. Virtual instruments offer the ability to select input waveforms and probe circuit nodes, voltages, and waveforms, creating a dynamic quick-start tool.

#### Note

These files require that either the TINA software or TINA-TI software be installed. Download the free TINA-TI simulation software from the TINA-TI™ software folder.

## 8.2 Documentation Support

### 8.2.1 Related Documentation

For related documentation see the following:

- Texas Instruments, Highly-Accurate, Loop-Powered, 4mA to 20mA Field Transmitter With HART Modem reference design
- Texas Instruments, Micropower Electrochemical Gas Sensor Amplifier reference design
- Texas Instruments, Compensate Transimpedance Amplifiers Intuitively application report
- · Texas Instruments, Designing With pH Electrodes application report

## 8.3 Receiving Notification of Documentation Updates

To receive notification of documentation updates, navigate to the device product folder on ti.com. Click on *Notifications* to register and receive a weekly digest of any product information that has changed. For change details, review the revision history included in any revised document.

## 8.4 Support Resources

TI E2E<sup>™</sup> support forums are an engineer's go-to source for fast, verified answers and design help — straight from the experts. Search existing answers or ask your own question to get the quick design help you need.

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#### 8.5 Trademarks

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Bluetooth® is a registered trademark of Bluetooth SIG. Inc.

PSpice® is a registered trademark of Cadence Design Systems, Inc.

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### 8.6 Electrostatic Discharge Caution



This integrated circuit can be damaged by ESD. Texas Instruments recommends that all integrated circuits be handled with appropriate precautions. Failure to observe proper handling and installation procedures can cause damage.

ESD damage can range from subtle performance degradation to complete device failure. Precision integrated circuits may be more susceptible to damage because very small parametric changes could cause the device not to meet its published specifications.

### 8.7 Glossary

TI Glossary

This glossary lists and explains terms, acronyms, and definitions.

## 9 Revision History

NOTE: Page numbers for previous revisions may differ from page numbers in the current version.

_	hanges from Revision D (April 2024) to Revision E (October 2024)	Page
•	Changed status of OPA2391 in DGK (VSSOP, 8) package from preview to production data (active)	1
•	Changed the load condition for Gain-bandwidth product from 10kΩ to no load	7
•	Changed the min AOL of OPA4391 for the low supply condition from 90dB to 86dB based on the lates	st
	characterization data	
•	Changed the load condition for Gain-bandwidth product from 10kΩ to no load	9
С	hanges from Revision C (December 2022) to Revision D (April 2024)	Page
•	Changed status of OPA4391 in PW (TSSOP, 14) package from preview to production data (active)	1
•	Added minimum value for Short-circuit current	
•	Changed the typical value of Open-loop output impedance from $500\Omega$ to $1.6k\Omega$ to match the typical	
	characteristic curve	7
_	Changed I <sub>Q</sub> from 24 µA to 23.5 µA based on the latest characterization data	7
_	Onanged IQ IIOIII 24 μΛ to 20.0 μΛ based on the latest characterization data	
С	hanges from Revision B (November 2022) to Revision C (December 2022)	Page
<u>C</u>	hanges from Revision B (November 2022) to Revision C (December 2022)  Changed status of OPA2391 in YBJ (DSBGA, 9) package from advanced information (preview) to pro	Page duction
•	hanges from Revision B (November 2022) to Revision C (December 2022)	Page duction
•	hanges from Revision B (November 2022) to Revision C (December 2022)  Changed status of OPA2391 in YBJ (DSBGA, 9) package from advanced information (preview) to product data (active) and added associated content	Page duction1
•	hanges from Revision B (November 2022) to Revision C (December 2022)  Changed status of OPA2391 in YBJ (DSBGA, 9) package from advanced information (preview) to product (active) and added associated content	Page duction1
•	hanges from Revision B (November 2022) to Revision C (December 2022)  Changed status of OPA2391 in YBJ (DSBGA, 9) package from advanced information (preview) to product (active) and added associated content	Page duction1 Page1
<u>C</u> :	hanges from Revision B (November 2022) to Revision C (December 2022)  Changed status of OPA2391 in YBJ (DSBGA, 9) package from advanced information (preview) to pro data (active) and added associated content	Page duction1 Page1
<u>C</u> :	hanges from Revision B (November 2022) to Revision C (December 2022)  Changed status of OPA2391 in YBJ (DSBGA, 9) package from advanced information (preview) to product (active) and added associated content	Page duction1 Page1 s

# 10 Mechanical, Packaging, and Orderable Information

The following pages include mechanical packaging and orderable information. This information is the most current data available for the designated devices. This data is subject to change without notice and revision of this document. For browser-based versions of this data sheet, refer to the left-hand navigation.

www.ti.com 23-May-2025

### PACKAGING INFORMATION

Orderable part number	Status	Material type	Package   Pins	Package qty   Carrier	RoHS	Lead finish/	MSL rating/	Op temp (°C)	Part marking
	(1)	(2)			(3)	Ball material	Peak reflow		(6)
						(4)	(5)		
OPA2391DGKR	Active	Production	VSSOP (DGK)   8	2500   LARGE T&R	Yes	NIPDAU	Level-2-260C-1 YEAR	-40 to 125	3BKS
OPA2391DGKR.A	Active	Production	VSSOP (DGK)   8	2500   LARGE T&R	Yes	NIPDAU	Level-2-260C-1 YEAR	-40 to 125	3BKS
OPA2391YBJR	Active	Production	DSBGA (YBJ)   9	3000   LARGE T&R	Yes	SNAGCU	Level-1-260C-UNLIM	-40 to 125	O91
OPA2391YBJR.A	Active	Production	DSBGA (YBJ)   9	3000   LARGE T&R	Yes	SNAGCU	Level-1-260C-UNLIM	-40 to 125	O91
OPA2391YBJT	Active	Production	DSBGA (YBJ)   9	250   SMALL T&R	Yes	SNAGCU	Level-1-260C-UNLIM	-40 to 125	O91
OPA2391YBJT.A	Active	Production	DSBGA (YBJ)   9	250   SMALL T&R	Yes	SNAGCU	Level-1-260C-UNLIM	-40 to 125	O91
OPA391DCKR	Active	Production	SC70 (DCK)   5	3000   LARGE T&R	Yes	NIPDAU	Level-2-260C-1 YEAR	-40 to 125	1EJ
OPA391DCKR.A	Active	Production	SC70 (DCK)   5	3000   LARGE T&R	Yes	NIPDAU	Level-2-260C-1 YEAR	-40 to 125	1EJ
OPA391DCKT	Active	Production	SC70 (DCK)   5	250   SMALL T&R	Yes	NIPDAU	Level-2-260C-1 YEAR	-40 to 125	1EJ
OPA391DCKT.A	Active	Production	SC70 (DCK)   5	250   SMALL T&R	Yes	NIPDAU	Level-2-260C-1 YEAR	-40 to 125	1EJ
OPA4391PWR	Active	Production	TSSOP (PW)   14	3000   LARGE T&R	Yes	NIPDAU	Level-2-260C-1 YEAR	-40 to 125	OPA4391
OPA4391PWR.A	Active	Production	TSSOP (PW)   14	3000   LARGE T&R	Yes	NIPDAU	Level-2-260C-1 YEAR	-40 to 125	OPA4391

<sup>(1)</sup> Status: For more details on status, see our product life cycle.

Multiple part markings will be inside parentheses. Only one part marking contained in parentheses and separated by a "~" will appear on a part. If a line is indented then it is a continuation of the previous line and the two combined represent the entire part marking for that device.

<sup>(2)</sup> Material type: When designated, preproduction parts are prototypes/experimental devices, and are not yet approved or released for full production. Testing and final process, including without limitation quality assurance, reliability performance testing, and/or process qualification, may not yet be complete, and this item is subject to further changes or possible discontinuation. If available for ordering, purchases will be subject to an additional waiver at checkout, and are intended for early internal evaluation purposes only. These items are sold without warranties of any kind.

<sup>(3)</sup> RoHS values: Yes, No, RoHS Exempt. See the TI RoHS Statement for additional information and value definition.

<sup>(4)</sup> Lead finish/Ball material: Parts may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

<sup>(5)</sup> MSL rating/Peak reflow: The moisture sensitivity level ratings and peak solder (reflow) temperatures. In the event that a part has multiple moisture sensitivity ratings, only the lowest level per JEDEC standards is shown. Refer to the shipping label for the actual reflow temperature that will be used to mount the part to the printed circuit board.

<sup>(6)</sup> Part marking: There may be an additional marking, which relates to the logo, the lot trace code information, or the environmental category of the part.



# PACKAGE OPTION ADDENDUM

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# **PACKAGE MATERIALS INFORMATION**

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## TAPE AND REEL INFORMATION





	Dimension designed to accommodate the component width
В0	Dimension designed to accommodate the component length
K0	Dimension designed to accommodate the component thickness
W	Overall width of the carrier tape
P1	Pitch between successive cavity centers

### QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE

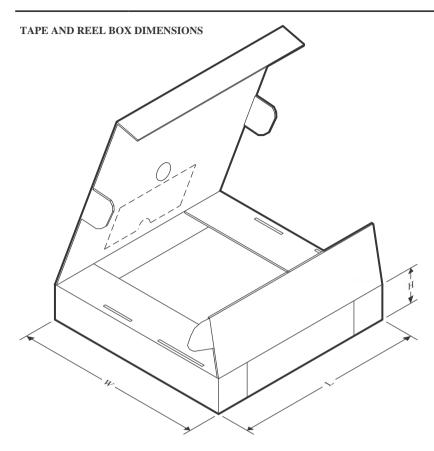


#### \*All dimensions are nominal

Device	Package Type	Package Drawing		SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
OPA2391DGKR	VSSOP	DGK	8	2500	330.0	12.4	5.3	3.4	1.4	8.0	12.0	Q1
OPA2391YBJR	DSBGA	YBJ	9	3000	180.0	8.4	1.26	1.26	0.43	4.0	8.0	Q1
OPA2391YBJT	DSBGA	YBJ	9	250	180.0	8.4	1.26	1.26	0.43	4.0	8.0	Q1
OPA391DCKR	SC70	DCK	5	3000	178.0	9.0	2.4	2.5	1.2	4.0	8.0	Q3
OPA391DCKT	SC70	DCK	5	250	178.0	9.0	2.4	2.5	1.2	4.0	8.0	Q3
OPA4391PWR	TSSOP	PW	14	3000	330.0	12.4	6.9	5.6	1.6	8.0	12.0	Q1



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## \*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
OPA2391DGKR	VSSOP	DGK	8	2500	353.0	353.0	32.0
OPA2391YBJR	DSBGA	YBJ	9	3000	182.0	182.0	20.0
OPA2391YBJT	DSBGA	YBJ	9	250	182.0	182.0	20.0
OPA391DCKR	SC70	DCK	5	3000	190.0	190.0	30.0
OPA391DCKT	SC70	DCK	5	250	190.0	190.0	30.0
OPA4391PWR	TSSOP	PW	14	3000	353.0	353.0	32.0





### NOTES:

PowerPAD is a trademark of Texas Instruments.

- 1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.

  2. This drawing is subject to change without notice.

  3. This dimension does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not
- exceed 0.15 mm per side.
- 4. This dimension does not include interlead flash. Interlead flash shall not exceed 0.25 mm per side.
- 5. Reference JEDEC registration MO-187.





NOTES: (continued)

- 6. Publication IPC-7351 may have alternate designs.
- 7. Solder mask tolerances between and around signal pads can vary based on board fabrication site.
- 8. Vias are optional depending on application, refer to device data sheet. If any vias are implemented, refer to their locations shown on this view. It is recommended that vias under paste be filled, plugged or tented.
- 9. Size of metal pad may vary due to creepage requirement.





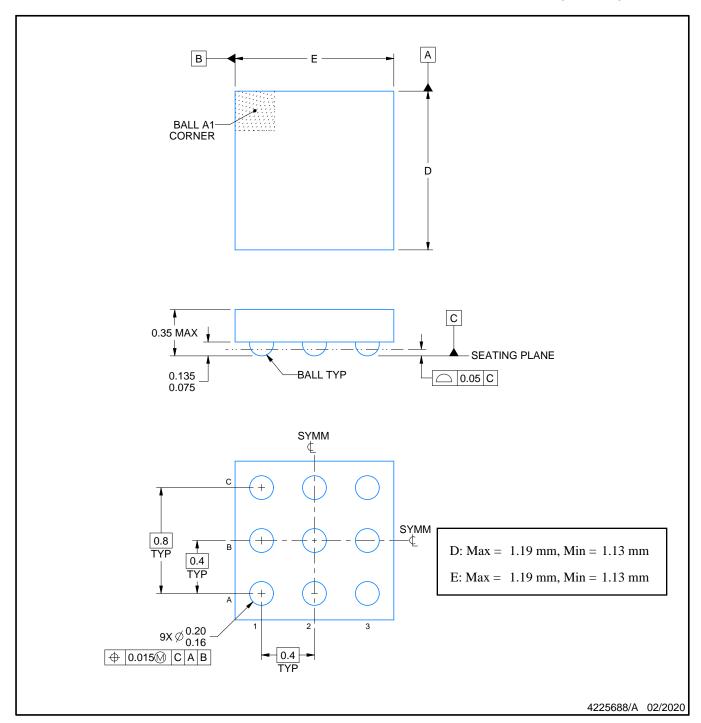
NOTES: (continued)

- 11. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
- 12. Board assembly site may have different recommendations for stencil design.





DIE SIZE BALL GRID ARRAY



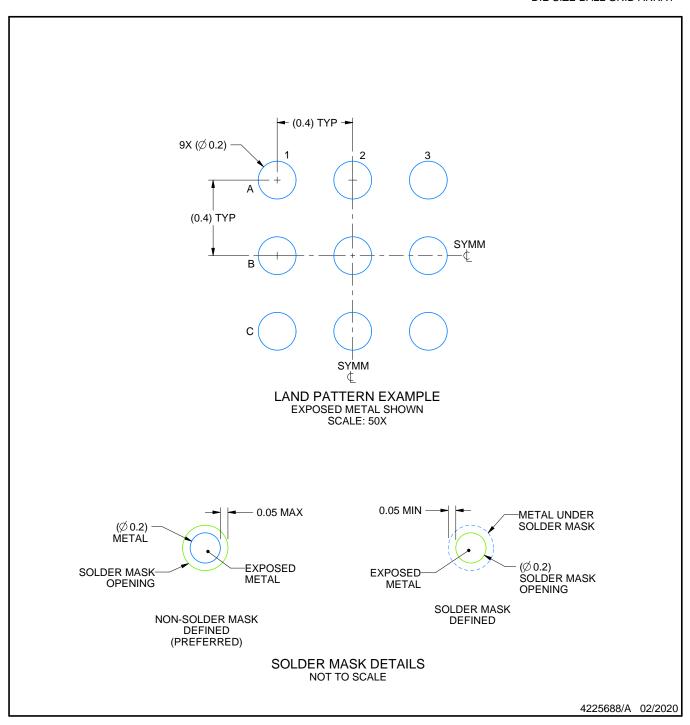
### NOTES:

- 1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.

  2. This drawing is subject to change without notice.



DIE SIZE BALL GRID ARRAY

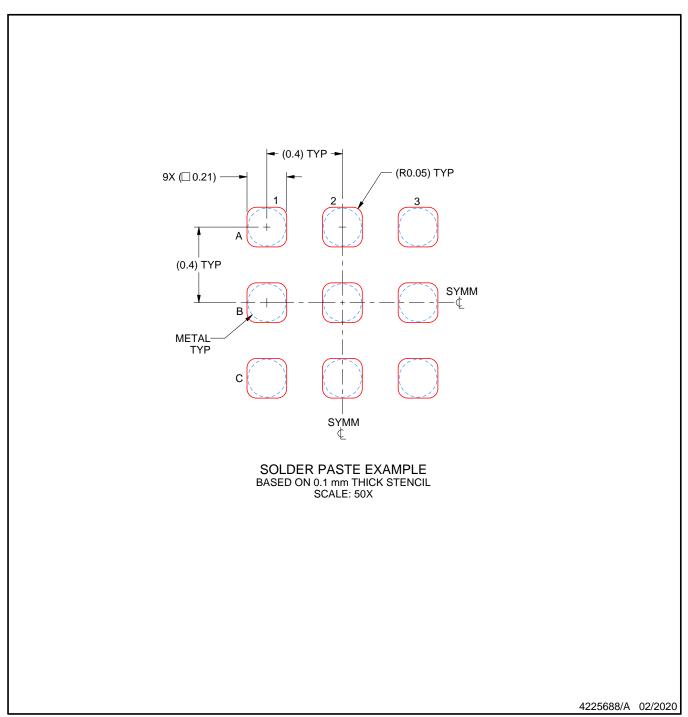


NOTES: (continued)

Final dimensions may vary due to manufacturing tolerance considerations and also routing constraints. See Texas Instruments Literature No. SNVA009 (www.ti.com/lit/snva009).



DIE SIZE BALL GRID ARRAY



NOTES: (continued)

4. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release.





SMALL OUTLINE TRANSISTOR



### NOTES:

- 1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.
  2. This drawing is subject to change without notice.
  3. Reference JEDEC MO-203.

- 4. Support pin may differ or may not be present.5. Lead width does not comply with JEDEC.
- 6. Body dimensions do not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed 0.25mm per side



SMALL OUTLINE TRANSISTOR



NOTES: (continued)

7. Publication IPC-7351 may have alternate designs.8. Solder mask tolerances between and around signal pads can vary based on board fabrication site.



SMALL OUTLINE TRANSISTOR



NOTES: (continued)

- 9. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
- 10. Board assembly site may have different recommendations for stencil design.







### NOTES:

- 1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.

  2. This drawing is subject to change without notice.

  3. This dimension does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not
- exceed 0.15 mm per side.
- 4. This dimension does not include interlead flash. Interlead flash shall not exceed 0.25 mm per side.
- 5. Reference JEDEC registration MO-153.





NOTES: (continued)

6. Publication IPC-7351 may have alternate designs.

7. Solder mask tolerances between and around signal pads can vary based on board fabrication site.





NOTES: (continued)

- 8. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
- 9. Board assembly site may have different recommendations for stencil design.



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